

SPECIFICATION FOR APPROVAL

DESCRIPTION: 1.43"OLED Module
CUSTOMER: BR143504-A1 V0
Product No:
Released Date: 2024.03.20
Revision: V0

PLEASE RETURN TO US ONE COPY OF"SPECIFICATION
FOR APPROVAL"WITH YOUR APPROVED SIGNATURES.

APPROVED SIGNATURES		

Table of Contents

Table of Contents.....	2
Record of Revision.....	3
1 General Specifications.....	4
2 Input/output Terminals.....	5
2.1 Main FPC Pin Assignment.....	5
2.2 Circuit block diagram (Display).....	8
2.3 MCU and Display Module Interface Configuration.....	8
3 Absolute Maximum Ratings.....	9
3.1 Driving AMOLED Panel.....	9
4 Electrical Characteristics.....	9
4.1 Driving AMOLED Panel.....	9
5 ACC hara cteristics.....	11
5.1 MIPI Interface Characteristics.....	11
5.2 Display RESET Timing Characteristics.....	13
5.3 TE Timing Characteristics.....	14
6 Recommended Operating Sequence.....	15
6.1 Display Power on / off Sequence.....	15
6.2 Brightness control.....	15
7 Optical Characteristics Optical Specification.....	17
8 Environmental / Reliability Test.....	23
9 Quality Level.....	24
9.1 AMOLED Module of Characteristic In spection.....	24
9.2 Sampling Procedures for each item acceptance table.....	24
9.3 In spection Item.....	24
10 Mechanical Drawing.....	32
11 Precautions for Use of AMOLED Modules.....	33
11.1 Handling Precautions.....	33
11.2 Storage Precautions:.....	33
11.3 Transportation Precautions:.....	33

Record of Revision

Rev	Issue Date	Description	Editor
A0	2023-03-20	Draft	CLM

1 General Specifications

Feature		Spec	Remark
Display Spec	Screen Size (inch)	1.43	
	Display Mode	AMOLED	
	Resolution(dot)	466(W)×466(H)	
	Active Area(mm)	36.348(W)×36.348 (H)	
	Pixel Pitch (um)	63.2 (W)×63.2(H)	
	Technology Type	LTPS	
	Color Depth	16.7M	
	Interface	MIPI 1LANE	
	Surface Treatment	Hard Coating	
Mechanical Characteristics	TP Outline	--	
	Module Outline Dimension(W x H x D) (mm)	39.15(W)x39.23(H)x0.8(D)	
	Weight (g)	TBD	
Electronic	Driver IC(Type)	CO5300	
	Touch IC(Type)	CST820	

Note 1: Requirements on Environmental Protection: RoHS.

2 Input/output Terminals

2.1 Main FPC Pin Assignment

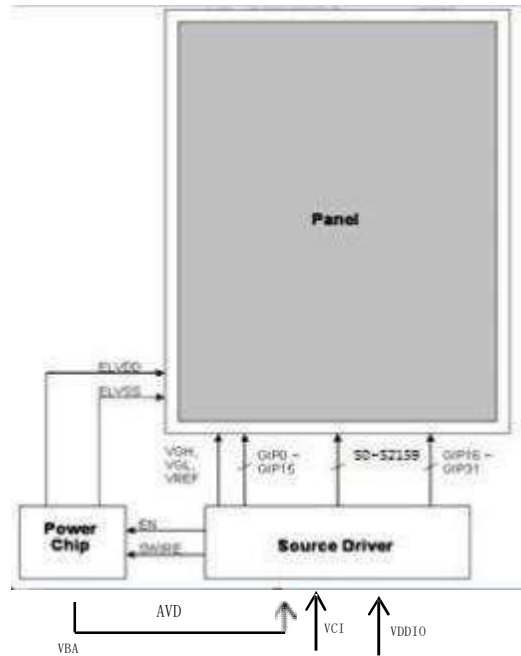
FPC connector: AXG230144.

No	Symbol	I/O	Description
1	GND	GND	GND
2	GND	GND	GND
3	SCL_CTP	I	SCL Pin for TP
4	INT_CTP	I	INT Pin for TP
5	GND	GND	GND
6	MIPI_CLKP_AM	I	MIPI clock lane
7	MIPI_CLKN_AM	I	MIPI clock lane
8	GND	GND	GND
9	MIPI_D0P_AM	I/O	MIPI data lane
10	MIPI_D0N_AM	I/O	MIPI data lane
11	GND	GND	GND
12	MTP	P	Power supply for MTP Programming or Erase.If it is not used,please let it open
13	GND	GND	GND
14	ELVSS	P	Negative Power supply for EL

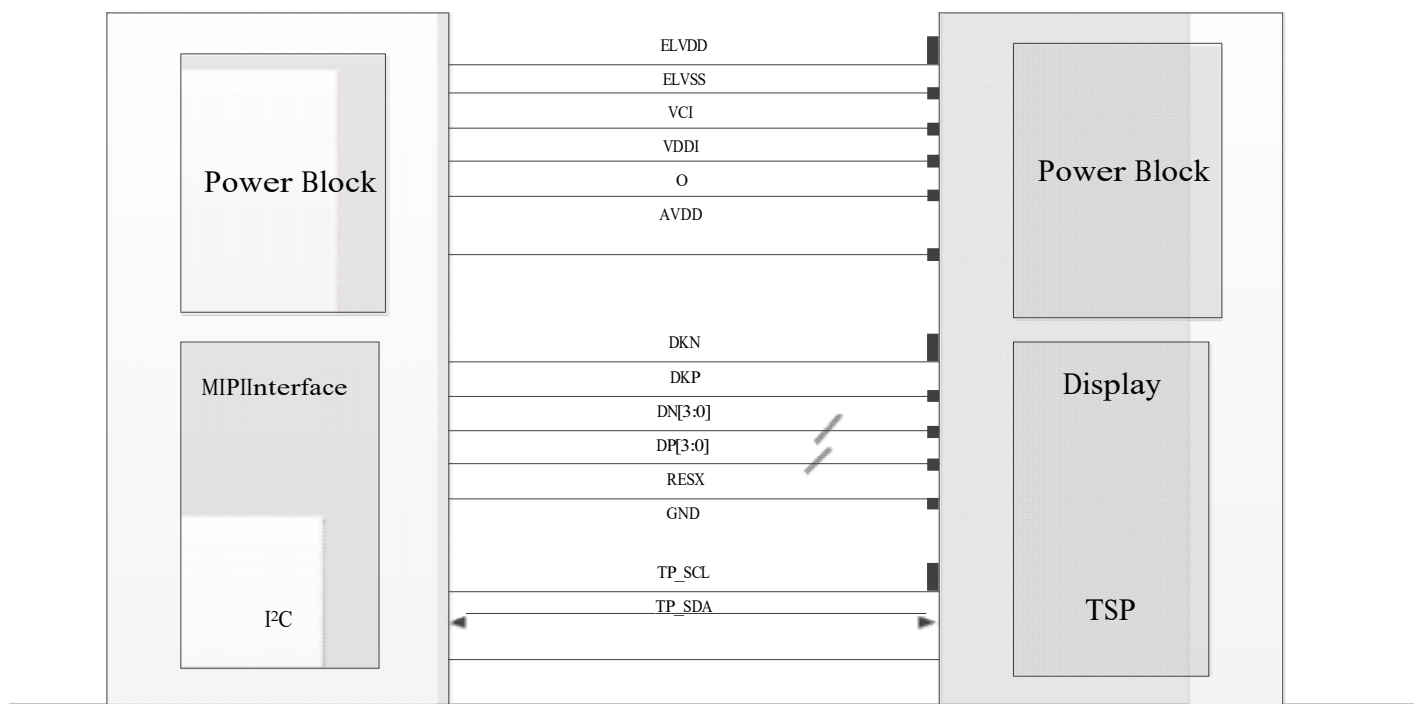
15	ELVSS	P	Negative Power supply for EL
16	ELVDD	P	Positive Power supply for EL
17	ELVDD	P	Positive Power supply for EL
18	VDD_AM	P	Power Supply for Analog circuit
19	VDDIO_AM	P	Power Supply for display logic circuit
20	RESET_AM	I	Display reset. Active low
21	TE_AM	I	Sync Signal for preventing Tearing Effect
22	SWIRE_AM	O	DC/DC Power IC S-Wire CTRL Pin
23	GND	GND	GND
24	VDDIO_CTP	P	I/O Power for TP
25	VDD_CTP	P	Analog Power for TP
26	SWDIO_CTP	I/O	serial wire debug input/output GND
27	RESET_CTP	I	Reset Pin for TP, Active
28	SDA_CTP	I/O	SDA pin for TP
29	GND	GND	GND
30	GND	GND	GND

Note: I=Input; O=Output; P=Power; I/O=Input / Output

2.2 Circuit block diagram (Display)



2.3 MCU and Display Module Interface Configuration



3 Absolute Maximum Ratings

3.1 Driving AMOLED Panel

Maximum Ratings (Voltage Referenced to VSS) Vss = 0V, Ta=25C

Item	Symbol	MIN	MAX	Unit
Analog Powersupply	VCI	-0.3	+5.5	V
Logic Power supply	VDDIO	-0.3	+5.5	V
Positive Power Input	ELVDD	-0.3	+5.5	V
Negative Power Input	ELVSS	-4.4	-0.3	V
Analog Powersupply	AVDD	-0.3	6.6	V
Analog Power for TP	VDD-CTP	-0.3	3.6	V

Note: Functional operation should satisfy the limit sin the Electrical Characteristic stables or Pin

Description section. If the module exceeds the absolute maximum ratings, permanent damage may occur. Besides, if the module is operated with the absolute maximum ratings for along time, there liability may also drop.

4 Electrical Characteristics

4.1 Driving AMOLED Panel

Item		Symbol	MIN	TYP	MAX	Unit
Logic Power supply		VDDIO	1.65	1.80	3.3	V
Analog Powersupply		VCI	2.75	2.8	3.60	V
ELVDD Supply Voltage		ELVDD	2.0	-	5.0	V
ELVSS Supply Voltage		ELVSS	-5.0		-0.5	V
Interface operating voltage		AVDD	-	-	-	V
Analog Supply Voltage		VDD-CTP	2.8	3.0	3,6	V
Input Signal Voltage	High Level	VIH	0.80*VDDIO	-	VDDIO	V
	Low Level	VIL	0.00	-	0.20*VDDIO	V
Output Signal Voltage	High Level	VOH	0.80*VDDIO	-	VDDIO	V
	Low Level	VOL	0.00	-	0.20*VDDIO	V
Normal		I _{ELVDD}	-	-	160	mA
		I _{ELVSS}	-	-	130	mA
		I _{VCI}	-	-	7	mA
		I _{VDDIO}	-	-	3.5	mA
		I _{avdd}	-	-	-	mA
Stand-by		I _{VCI}	-	-	2	uA
		I _{VDDIO}	-	-	4	uA

Ta=25C

Note1: The input digital voltage is the I/O reference voltage.

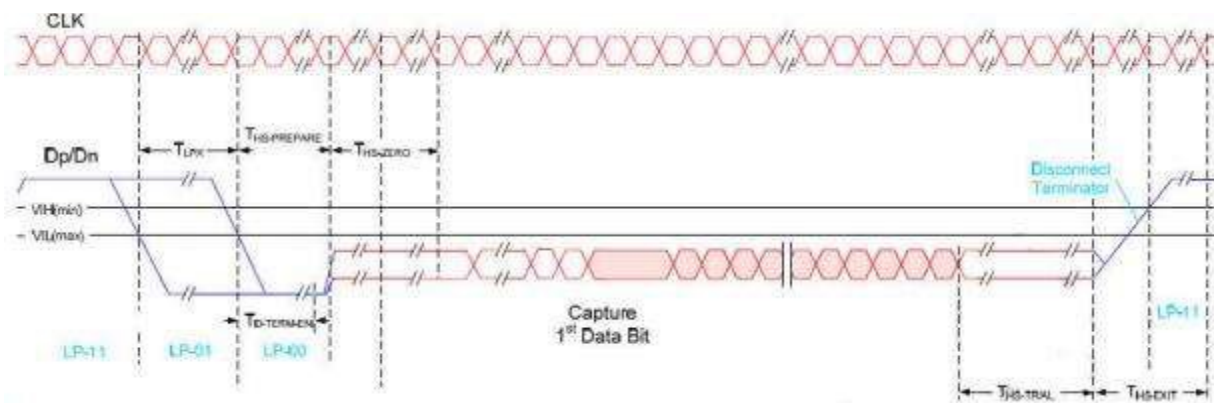
Note2: VDDIO usually ranges from 1.65V to 3.3 V. If VDDIO is changed, the remaining voltage Needs to be changed to the same voltage as VDDIO.

Note3: Under full white pattern, Video Mode 60.5Hz. Note4:
60Hz command mode at 896 Mbp

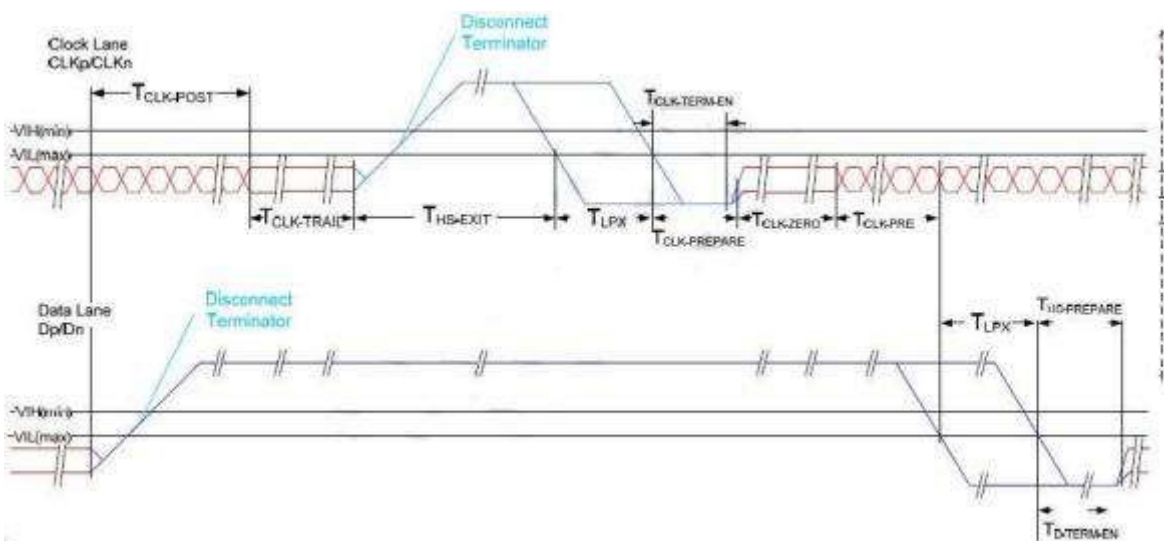
5AC Characteristics

5.1 MIPI Interface Characteristics

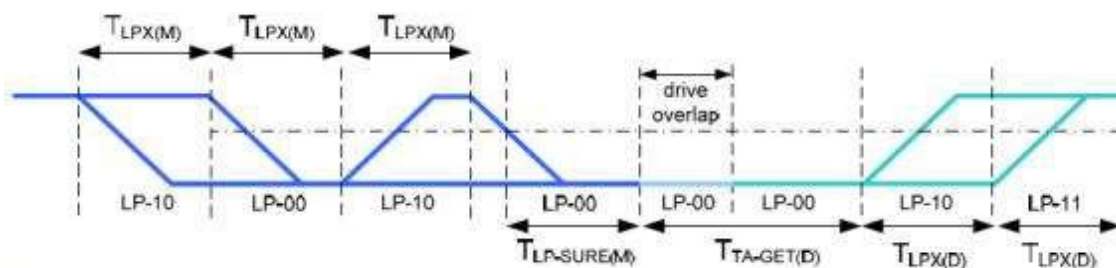
HS Data Transmission Burst



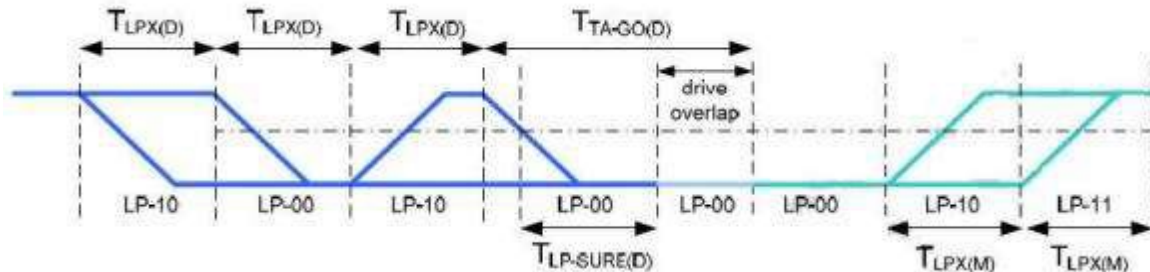
HS clock transmission



Turnaround Procedure



Bus turnaround (BAT) from MPU to display module timing



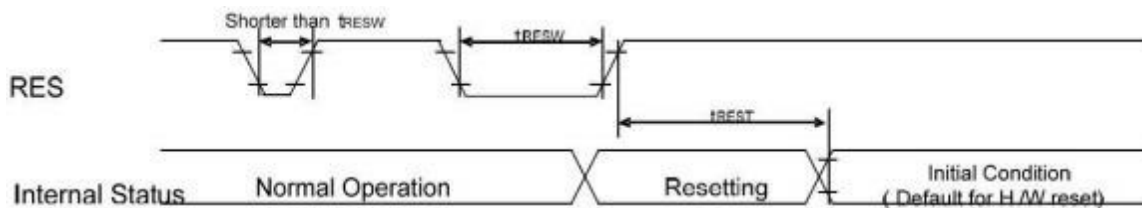
Timing Parameters:

Parameter	Description	Min	Typ	Max	Unit
$T_{CLK-POST}$	Time that the transmitter continues to send HS clock after the last associated Data Lane has transitioned to LP Mode. Interval is defined as the period from the end of $T_{HS-TRAIL}$ to the beginning of $T_{CLK-TRAIL}$.	$60ns + 52*UI$			ns
$T_{CLK-TRAIL}$	Time that the transmitter drives the HS-0 state after the last payload clock bit of a HS transmission burst.	60			ns
$T_{HS-EXIT}$	Time that the transmitter drives LP-11 following a HS burst.	300			ns
$T_{CLK-TERM-EN}$	Time for the Clock Lane receiver to enable the HS line termination, starting from the time point when Dn crosses $V_{IL,MAX}$.	Time for Dn to reach $V_{TERM-EN}$		38	ns
$T_{CLK-PREPARE}$	Time that the transmitter drives the Clock Lane LP-00 Line state immediately before the HS-0 Line state starting the HS transmission.	38		95	ns
$T_{CLK-PRE}$	Time that the HS clock shall be driven by the transmitter prior to any associated Data Lane beginning the transition from LP to HS mode.	8			UI
$T_{CLK-PREPARE} + T_{CLK-ZERO}$	$T_{CLK-PREPARE}$ + time that the transmitter drives the HS-0 state prior to starting the Clock.	300			ns
$T_{D-TERM-EN}$	Time for the Data Lane receiver to enable the HS line termination, starting from the time point when Dn crosses $V_{IL,MAX}$.	Time for Dn to reach $V_{TERM-EN}$		$35 ns + 4*UI$	
$T_{HS-PREPARE}$	Time that the transmitter drives the Data Lane LP-00 Line state immediately before the HS-0 Line state starting the HS transmission	$40ns + 4*UI$		$85 ns + 6*UI$	ns
$T_{HS-PREPARE} + T_{HS-ZERO}$	$T_{HS-PREPARE}$ + time that the transmitter drives the HS-0 state prior to transmitting the Sync sequence.	$145ns + 10*UI$			ns
$T_{HS-TRAIL}$	Time that the transmitter drives the flipped differential state after last payload data bit of a HS transmission burst	$60ns + 4*UI$			ns

Parameter	Description	Min	Typ	Max	Unit	Notes
$T_{LPX(M)}$	Transmitted length of any Low-Power state period of MCU to display module	50		150	ns	1,2
$T_{TA-SURE(M)}$	Time that the display module waits after the LP-10 state before transmitting the Bridge state (LP-00) during a Link Turnaround.	$T_{LPX(M)}$		$2 \cdot T_{LPX(M)}$	ns	2
$T_{LPX(D)}$	Transmitted length of any Low-Power state period of display module to MCU	50		150	ns	1,2
$T_{TA-GET(D)}$	Time that the display module drives the Bridge state (LP-00) after accepting control during a Link Turnaround.		$5 \cdot T_{LPX(D)}$		ns	2
$T_{TA-GO(D)}$	Time that the display module drives the Bridge state (LP-00) before releasing control during a Link Turnaround.		$4 \cdot T_{LPX(D)}$		ns	2
$T_{TA-SURE(D)}$	Time that the MPU waits after the LP-10 state before transmitting the Bridge state (LP-00) during a Link Turnaround.	$T_{LPX(D)}$		$2 \cdot T_{LPX(D)}$	ns	2

5.2 Display RESET Timing Characteristics

Reset n put timing:



VDDIO=1.65 to 3.3V, VDD=2.7 to 3.6V, AGND=DGND=0V, Ta=-40 to 85°C

Timing Parameters

Symbol	Parameter	Related Pins	MIN	TYP	MAX	Note	Unit
t_{RESW}	*1) Reset low pulse width	RESX	10	-	-	-	μs
t_{REST}	*2) Reset complete time	-	-	-	5	When reset applied during Sleep in mode	ms
		-	-	-	120	When reset applied during Sleep out mode	ms

Note1. Spike caused by an electrostatic discharge on RESX line does not cause irregular system reset according to the table below.

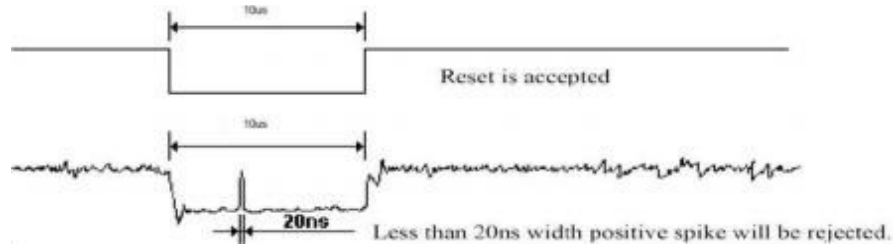
RESX Pulse	Action
Shorter than 5 μs	Reset Rejected
Longer than 10 μs	Reset
Between 5 μs and 10 μs	Reset starts (It depends on voltage and temperature condition.)

Note2. During the resetting period, the display will be blank (The display is entering blanking sequence).

whose maximum time is 120ms, when Reset Starts in Sleep Out-mode. The display remains blank in Sleep In-mode) and then return to Default condition for H/W reset.

Note3. During Reset Complete Time, data in OTP will be latched to internal register during this period. This loading is done very time when there is H/W reset complete time (t_{REST}) with in 5ms after rising edge of RESX.

Note4. Spike Rejection also applies during a valid reset pulse as shown below:



Note5. It is necessary to wait 5msec after releasing RESX before sending commands. Also Sleep Out command can not be sent for 120 msec.

5.3 TETimingCharacteristics

Mode1, The Tearing Effect Output line consists of V- Blanking information only.



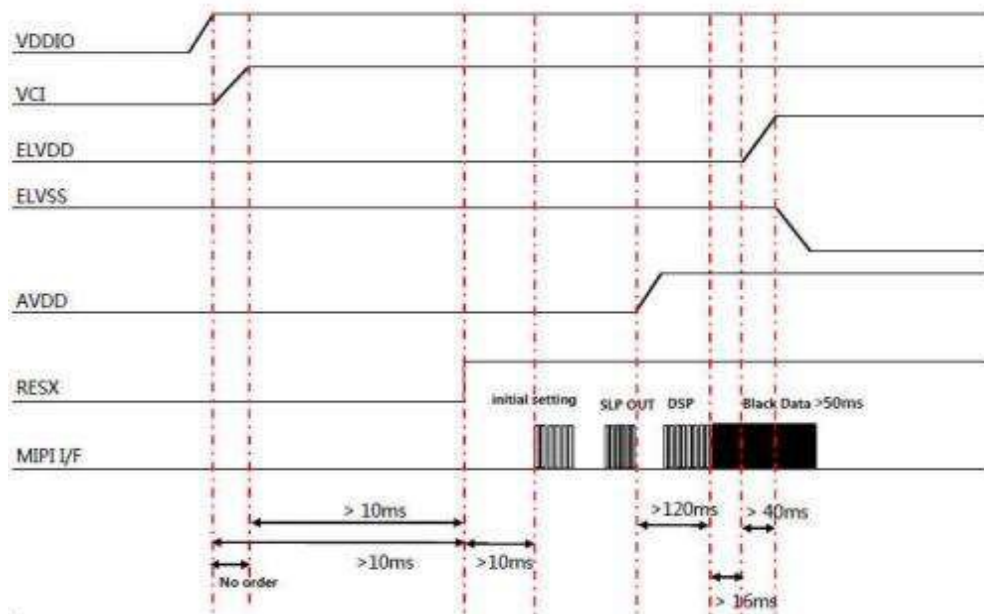
T_{vdh} = The display is not updated from the frame memory.

T_{vdl} = The display is updated from the frame memory.

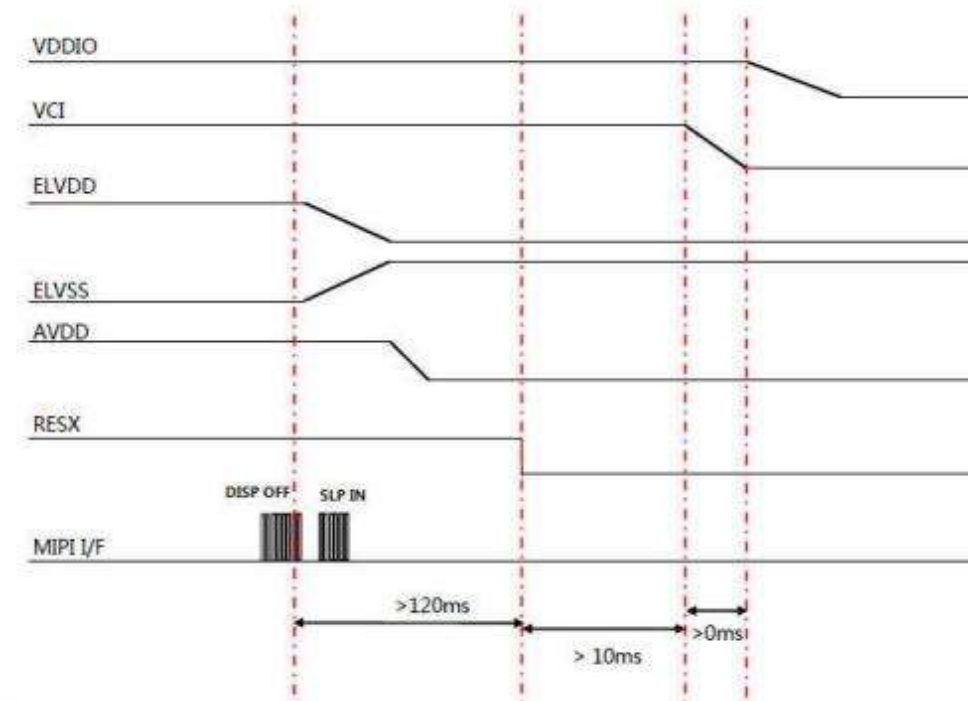
6 Recommended Operating Sequence

6.1 Display Power on / off Sequence

6.1.1 Power On Sequence



6.1.2 Power Off Sequence



6.2 2 Brightnesscontrol

Use “ command5 1 0 0 h, dataxxh” to adjust the Manual Brightness value of the display:

In principle relationship is that 0 0 h value means the lowest brightness and FF h value means the highest brightness.

Inst/Para	R/W	Address		Date Type	Description
		MIPI	Other		
BRTCTRL	W	51h	5100h	Hex	Value form 0~255(FF)

Optical Characteristics Optical Specification

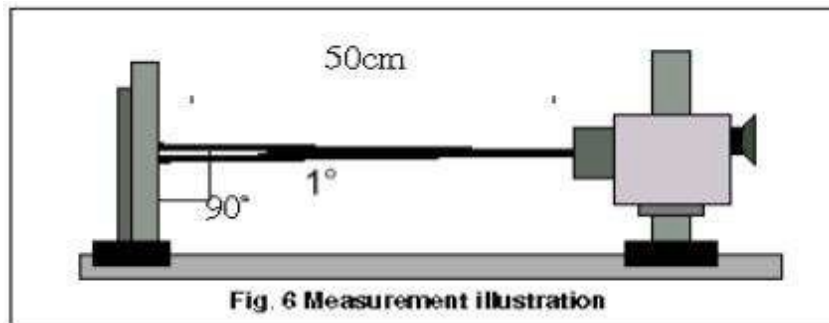
Item		Symbol	Condition	Min	Typ	Max	Unit	Remark
ViewAngle		θT	CR≥10	-	-	80	Degree	Note2 TestEquipment: CS2000A
		θB		-	-	80		
		θL		-	-	80		
		θR		-	-	80		
Contrast Ratio		CR	θ=0°	100000				Note1 Note3 Test Equipment: CS2000A
ResponseTime		T _{ON}	2 5 C			1	ms	Note1 Note4 TestEquipment: AdmesyMSE
		T _{OFF}						
Chromaticity	White	x		(0.280)	(0.300)	(0.320)		Test Equipment: CS2000A Note: Chromaticitycan be modified accordingtocustomer demand
		y		(0.290)	(0.310)	(0.330)		
	Red	x		(0.650)	(0.680)	(0.710)		
		y		(0.285)	(0.315)	(0.345)		
	Green	x		(0.210)	(0.250)	(0.290)		
		y		(0.670)	(0.710)	(0.750)		
	Blue	x		(0.110)	(0.140)	(0.170)		
		y		(0.017)	(0.047)	(0.077)		
Uniformity		U		80	85		%	Note1 Note6 Test Equipment: CS2000A
NTSC				97	105		%	Note5
Luminance		L	Normal	305	450	495	Cd/m ²	Note1 Note7 Test Equipment: CS2000A
Cross-talk						2	%	Note8 Test Equipment: CS2000A

Gamma			2.0	2.2	2.4		Gamma=2.2±0.2 TestEquipment: CS2000A
-------	--	--	-----	-----	-----	--	--

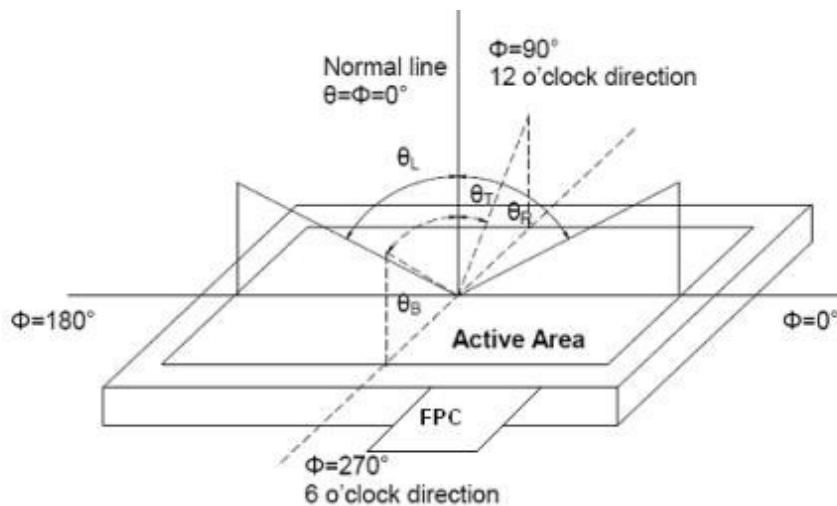
TestConditions:
theambienttemperatureis 2 5 C.
1. ThetestsystemsrefertoNote1 andNote2.

Note1: Definition of optical measurement system.

The optical characteristics should be measured in a dark room. The optical properties are measured at the center point of the AMOLED screen. All input terminals of the AMOLED panel must be grounded when measuring the center area of the panel.



Note 2: Definition of viewing angle range and measurement system.



Note 3: Definition of contrast ratio

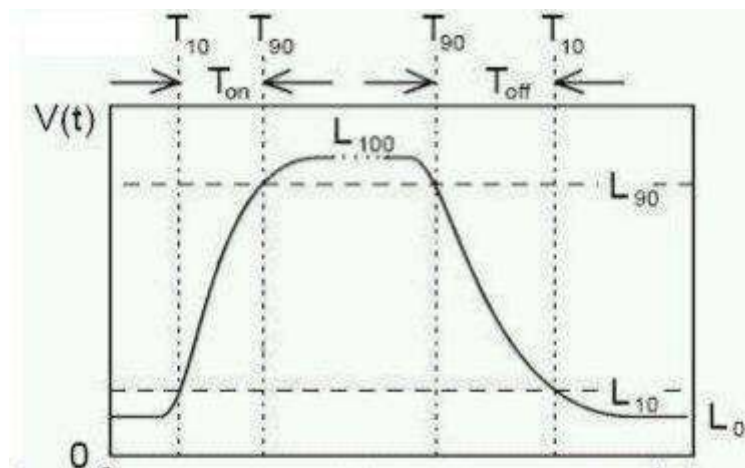
$$\text{Contrast ratio (CR)} = \frac{\text{Luminance measured when LCD is on the "white" state}}{\text{Luminance measured when LCD is on the "Black" state}}$$

“White state”: A state where the AMOLED should be driven by V_{white} .

“Black state”: A state where the AMOLED should be driven by V_{black} .

Note 4: Definition of response time

The response time is defined as the AMOLED optical switching time interval between “White” state and “Black” state. Rise time (T_{ON}) is the time between photodetector output intensity changing from 10% to 90%. And fall time (T_{OFF}) is the time between photodetector output intensity changing from 90% to 10%.



Note 5: Definition of color chromaticity (CIE1931)

Color coordinates are measured at the center point of AMOLED.

Note 6: Definition of luminance uniformity

Active area is divided into 9 measuring areas (Refer Fig. 2). Every measuring point is placed at the center of each measuring area.

$$\text{Luminance Uniformity}(U) = L_{\min} / L_{\max}$$

L-----Active area length W----- Active area width

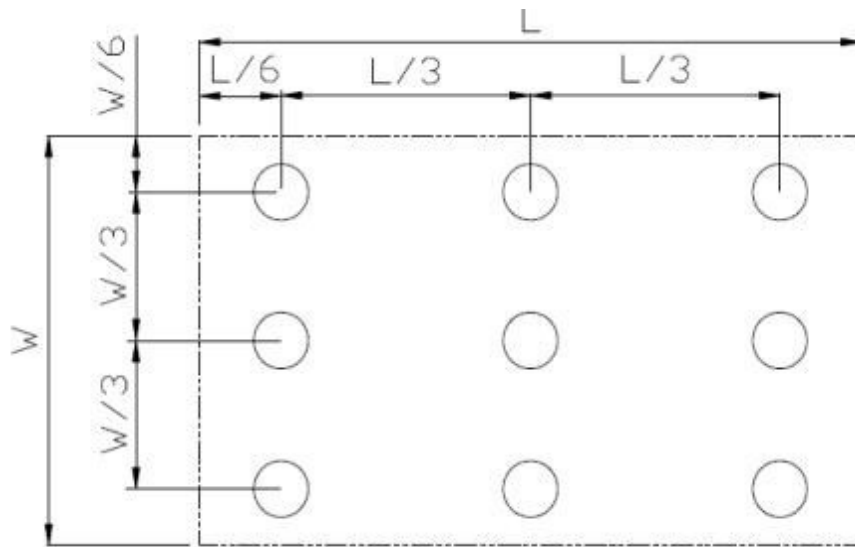


Fig. 2 Definition of uniformity

$L_{\max}$: The measured maximum luminance of all measurement position.

$L_{\min}$: The measured minimum luminance of all measurement position.

Note 7: Definition of luminance:

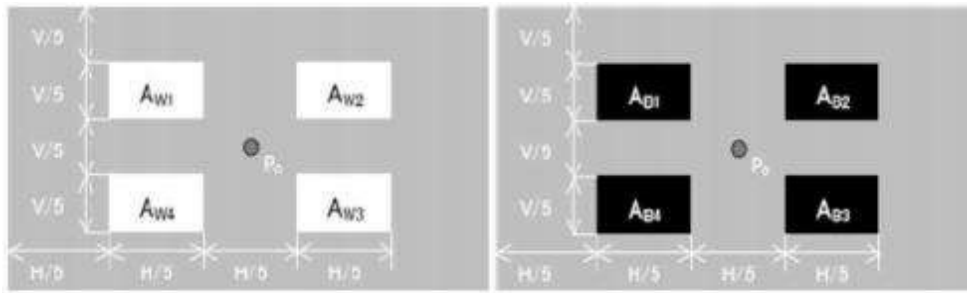
Measure the luminance of white state at the center point.

Note 8: Cross Talk

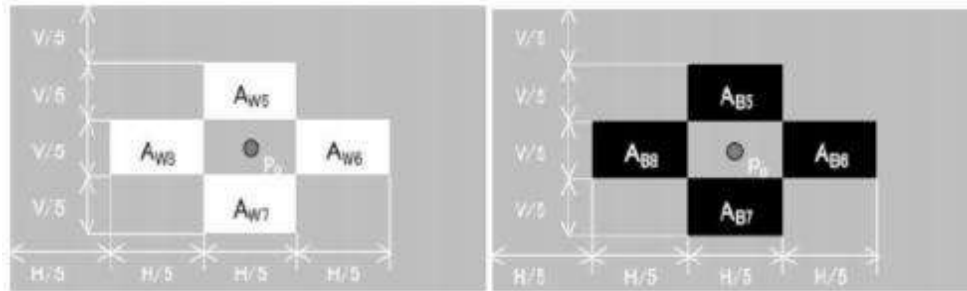
A. Measure luminance at the position, P0.

B. Calculate crosstalk as below equation.

$$\begin{aligned}
 & L_{W_OFF} = \frac{L_{W1} + L_{W2} + L_{W3} + L_{W4}}{4} \\
 & L_{B_OFF} = \frac{L_{B1} + L_{B2} + L_{B3} + L_{B4}}{4} \\
 & \text{crosstalk} = \frac{|L_{Wi_ON} - L_{W_OFF}|}{L_{W_OFF}} \times 100\% \quad (i = 5 \text{ to } 8) \\
 & \text{crosstalk} = \frac{|L_{Bi_ON} - L_{B_OFF}|}{L_{B_OFF}} \times 100\% \quad (i = 5 \text{ to } 8)
 \end{aligned}$$

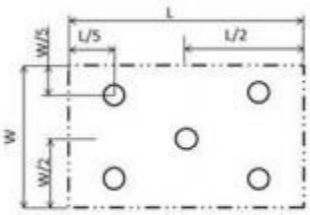


(a) L_{W_OFF} , L_{B_OFF} measuring pattern



(b) L_{W_ON} , L_{B_ON} measuring pattern

8Environmental/ReliabilityTest

No	TestItem	Condition	Remark
1	HighTemperature Operation	+70C, 240hrs	Accordingto the customer request
2	Low TemperatureOpe ration	-20C, 240hrs	Accordingto the customer request
3	HighTemperature Storage	+80C, 240hrs	Accordingto the customer request
4	Low TemperatureStor age	-30C, 240hrs	Accordingto the customer request
5	High Temperature &High Humidity Operation	60C, 90% RH,240hrs	Accordingto the customer request
6	High Temperature &High Humidity Storage	60C, 90% RH,240hrs	Accordingto the customer request
7	ThermalShock (Non- operation)	-30C(30 min)~+70C(30 min),Change time:10min, 30Cycles	Accordingto the customer request
8	ElectroStatic Discharge (Operation)	C=150pF, R=330Ω , 5points/panel Air:±8KV, 5times; Contact: ± 4 KV, 5 times; (Environment: 1 5 C~ 3 5 C, 3 0 %~ 6 0 % , 8 6 Kpa~ 1 0 6 Kpa) . 	IEC61000-4-2 GB/T17626.2

9 Quality Level

9.1 AMOLED Module of Characteristic Inspection

The environmental condition and visual inspection shall be conducted as below:

- (1) Ambient temperature: $23 \pm 3^{\circ}\text{C}$
- (2) Humidity: $55 \pm 10\%\text{RH}$
- (3) Ambient light intensity of visual inspection: 800 ~ 1200 lux
- (4) Ambient light intensity of function inspection: ≤ 200 lux
- (5) Viewing Distance: $30 \pm 5\text{cm}$
- (6) Viewing angle (tolerance): the front side $45^{\circ}(\text{Z}) \pm 15^{\circ}$
- (7) Inspection time: 10 ± 5 sec

9.2 2 Sampling Procedures for each item acceptance table

Defect type	Sampling Procedures	AQL
Major defect	GB/T2828.1-2003 Inspection level II normal inspection single sample inspection	0.65
Minor defect	GB/T2828.1-2003 Inspection level II normal inspection single sample inspection	1.0

Major defect:

Any defect may result in functional failure, or reduce the usability of product for its purpose.
For example, electrical failure, deformation and etc.

Minor defect

A defect does not reduce the usability of product for its intended purpose and uniformity, such as dot defect and etc.

The criteria on major and/or minor judgment will be according with the classification of defects.

9.3 Inspection Item

No.	Item	Area	Criterion of Defect			Defect type
1	Dot Defect	AA	Type	DS	Acceptable number	Minor
			Bright Dot	$\geq 10\text{mm}$	0	
			Dark Dot	$\geq 10\text{mm}$	4	
			Dark Dot ($\geq$ two)	$\geq 10\text{mm}$	2	

			connections)				
2	No Display	AA	/			Not allowed	Fatal
3	Abnormal Display	AA	/			Not allowed	Fatal
4	Normally white	AA	/			Not allowed	Fatal
5	Line Defect	AA	single line	Bright line		Not allowed	Fatal
				Dark line		Not allowed	
			Multiple lines	Bright line		Not allowed	
				Dark line		Not allowed	
			Half-Line	Bright line		Not allowed	
				Dark line		Not allowed	
6	Image sticking	AA	Switch to the next screen and display the image of the previous picture				Major
7	Color & Edge Mura	AA	See limit sample (under full white screen)				Major
8	Color crast	AA	See limit sample (under full white screen)				Major
9	Water Ripple	AA	Not allowed				Major
10	Other mura (Low gray-scale white spot, S-Line Mura)	AA	Not allowed (under full white screen) or See limit sample (under low gray-scale white screen)				Major
11	TP	AA	TP function NG			Not allowed	Fatal
12	Glass crack	AA, OA	/			Not allowed	Fatal
13	Screen bump	AA, OA	Encaps surface is not allowed and LTPS does not affect assembly				Major
14	Line defects (light visible)	AA	W (mm)	L (mm)	DS (mm)	Acceptable number	Minor
			$W \leq 0.03$	-	-	Ignore	
			$0.03 < W \leq 0.05$	$L \leq 5.0$	≥ 10	2	
			$0.05 < W$	-	-	0	
			-	$L > 5.0$	-	0	
15	Point defects (light visible)	AA	D (mm)	DS (mm)		Acceptable number	Minor
			$D \leq 0.1$	/		Ignore	

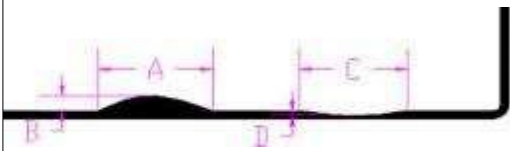
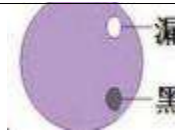
			$0.1 < D \leq 0.25$	≥ 1 0		2	
			$0.25 < D$			0	
16	Glass scratch	AA	W (mm)	L (mm)	DS (mm)	Acceptabl enumber	Minor
			$W \leq 0.03$	$L < 5.0$	≥ 10	Ignore	
			$0.03 < W \leq 0.05$	$L \leq 2.0$	≥ 10	Ignore	
				$2.0 < L \leq 5.0$	≥ 10	2	
			$0.05 < W$	-	0	0	
				$L > 5.0$	0	0	
17	FritEncapsulation	FA	Fritwidthuniformity. Itshouldnothavebubbleor breakage.				Major
18	Polarizercrease / indentation	AA	See limitsample				Minor
19	Protectivefilm starved/ overflow glue/ burr	Except AA	No control under $W \leq 0.3\text{mm}$				Minor
20	Polarizerbump point	Whole area	Bump: $D \leq 0.25\text{mm}$, dent $\leq 1\text{mm}$ orSeelimitsample		Allow 3		Minor
21	Polarizerbubble line	Outof AA, $\leq 0.25\text{ m m}$	Encap surface		Not allowed		Minor
22	Scratchesonthe surfaceof polarizer	Whole area	No harm subjectregardlessofcontrol				Minor
23	Concavedot、Blackandwhite dot、Polarizer Dent/ Bubble	AA	Front (Encap surface)	D (mm)	DS (mm)	Acceptabl enumber	Minor
				$D \leq 0.1$	≥ 10	Ignore	
				$0.1 < D \leq 0.2$	≥ 10	3	
				$0.2 < D$	≥ 10	0	
			Metalmaterial foreignmaterial	/	≥ 10	Not allowed	
24	PolarizerScratch/ Fiber(Linear)	AA	W (mm)	L (mm)	DS (mm)	Acceptabl enumber	Minor
			$W \leq 0.03$	$L \leq 5.0$	≥ 10	Ignore	
			$0.03 < W \leq 0.05$	$L \leq 2.0$	≥ 10	Ignore	
				$2.0 <$	≥ 10	3	

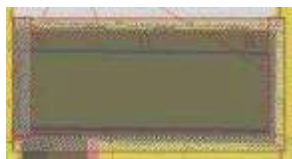
			0.05 < W	-	≥10	0	
				L>5.0	≥10	0	
25	Edge/Side breakage	OA	The following Criterion is applicable to any side (unit: mm)				Minor
			Z	X	Y	Acceptable number	
			≤ T	≤2.0	not extended to circuit Area or Frit	<5	
26	UV glue	Not IC side	Over coating			Not allowed	Minor
		IC side	The coating of IC side is no higher than POL.			Not allowed	
		IC side	The coating of IC side is no higher than POL.			Not allowed	
27	Tuffy glue	IC and FPC bonding area	The coatings should not have breakage or Bubble.				Minor
			The coating is no higher than POL.				
		Other area	Tuffy glue is not allowed to interrupt and the diameter of Bubble is not more than 0.5 mm.				
			The coating is no higher than POL.				
		IC	Not allowed				
FPC	Ribbon glue: the width is not more than 1 mm. Dot glue: the diameter is not more than 2 mm.						
28	Rear reinforcement glue of FPC	FPC	The width is not more than 1mm. The height is lower than LTPS.				Minor
29	ACF	Bonding Area	The length of attachment is more than both ends of FPC, which should be range from 0.2 to 1mm. Don't go beyond the edge of panel. Effective lap width of wiring ACF is more than 2/3, which is compared with the width of the gold finger of FPC. Don't have bubble or wrinkle.				Minor
30	FPCA	FPC	The component cannot reverse polarity				Minor
			Nowrong insertion				
			FPC should not have serious crease which destroy the line, prick and spots damage. Scratch is not allowed if Cu layer is exposed.				
			The gold fingers should not be oxidized, scraped, folded, impressed, broken, spotted or dissymmetry.				
			Make sure FPC is not scalded, with its location holes not having deficiency or obviously shift.				
			The component of FPC should be the same as BOM				

			list.	
			NoremainingsolderingSn	
			Novisualparticleonthepadline	
31	FPC bonding	Bondin garea	Bubble: Visiblebubbleisnotallowed	Minor
			Overhang: Thesizeabove 1 / 2 of soldering electrode of the part overhang to the LAND is prohibited. The tilt height less than 0 . 5 mm between FPC and foam.	
	FPC skew		Not allowed	
32	Package	Other	Productsshouldputintotheanti- static trays, with non-overlapping, and the traysshouldbestaggered placed	Minor
			Different products cannot be mixed into the same inner package.	
			The packages should not have obvious deformation or breakage . The printing label type and quantity are correct.	
			The packages should have QC signature. ROHS label is needed if the product is under ROHS control.	

Inspection standard for cover

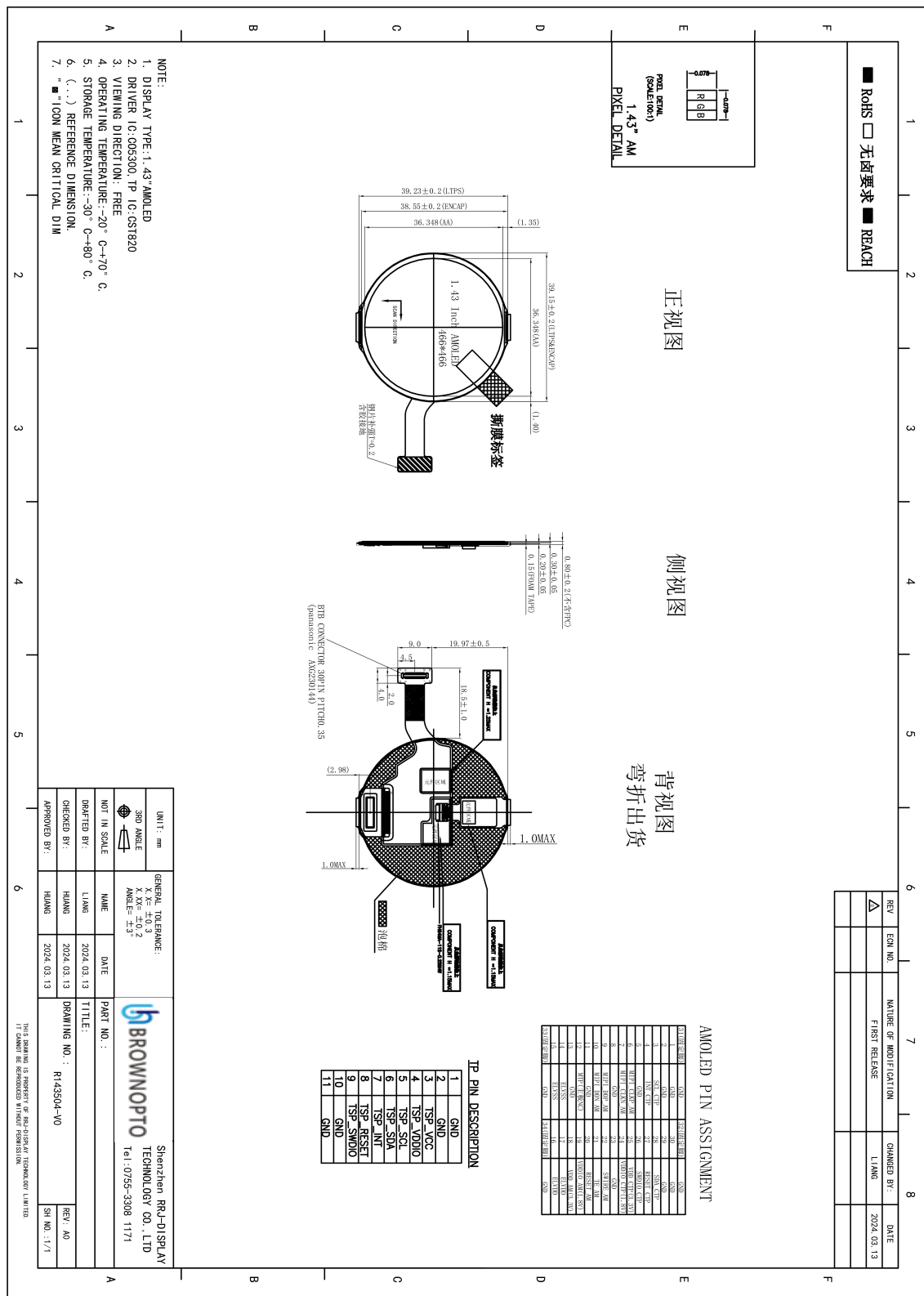
No	Item	Area	Criterion of Defect				Defect type
33	Cover dot、Black and white dot、Polarizer Dent/Bubble	Whole area	D (mm)		DS (mm)	Acceptable number	Minor
			D≤0.15mm		/	Ignore (specksis notallowed)	
			0. 15mm<D<0.25mm		DS≥10 mm	2	
			D>0.25 mm		/	Notallowed	
			Specks: D<0. 15mm，N>5 in 10 mm*10 mmarea				
34	Cover Scratch/Fiber (Linear)	AA	W(mm)	L(mm)	DS(mm)	Acceptable number	Minor
			W≤0.03 mm	L≤10mm	≥10	Ignore	
			0.03mm<W ≤0.05mm	L≤5.0mm	≥10	2	
			W>0.05	/	/	Not allowed	
			/	L>5.0mm	/	Not allowed	
			Notallowed toscratch				
35	Edge pinhole	Edge of cover	D (mm)	DS (mm)	Acceptable number		Minor
			D<0.1mm	DS≥10mm	one is allowed on each side		

36	Uneven edge of the ink	Edge of cover	W (BorD)	L(AorC)	Acceptable number	Minor
			$W \leq 0.15 \text{ mm}$	$L \leq 3 \text{ mm}$	≤ 2	
						
37	ink silk screen serrated	OA area	D (mm)	DS (mm)	Acceptable number	Minor
			$D \leq 0.2$	$DS \geq 10 \text{ mm}$	2	
38	Camera Hole	OA area	breakage or crack: $D \leq 0.1 \text{ mm}$			Minor
			Hole is not round: Refer to the limit sample			
			Dot Defect: $D \leq 0.1 \text{ mm}$, and $N \leq 1$, heterochromism and line defect are not allowed;			
			Camera hole mud: not allowed			
39	Printing defect	OA area	Wrongly、Missing、Ghosting and incomplete printing : not allowed			Minor
			Fonts consistent with the standard characters, no significant difference in visualization			
			Penetrating scratch is not allowed			
40	IR Hole/ Black spots/ Line scratch foreign matter/ Residue	OA area	DS (mm)	Acceptable number		Minor
			$DS < 0.1$	Ignore		
			$0.1 \leq DS \leq 0.15$	1		
			Note: Not visible on black background, don't affect the transmission rate			
			Foreign body, dirty in IR hole: not allowed			
			Scratched\ Line defects in IR hole: $W \leq 0.03 \text{ mm}$, $L \leq 1 \text{ mm}$, $N \leq 1$, Not visible on black background, don't affect the transmission rate.			
			Residual glue in IR hole: not allowed			
41	Cover lens deformation	OA area	Raised height $< 0.15 \text{ mm}$, and the area is less than 25 % of the entire non- display area in the cover lens			Minor
		AA area	Deformation is not allowed in AA area			

42	Poor penetration of icons	OA area	DS≤0.15 and N≤1		Minor
43	Cover dirt	Whole area	Not allowed		Minor
44	Cover crack				Fatal flaw
45	Cover paint chips				
46	Burr	Edge of cover	L≤0.05 mm, W<0.2 mm accept (The premise does not affect the assembly and function and user operation)		Minor
47	colour difference	OA area	No significant difference in visualization (refer to the limit sample if necessary)		
48	Overfill	Whole area	Not allowed in AA area		Minor
			The visible part of the periphery cannot be seen after assembly, and cannot affect the assembly		
49	Protective film	Whole area	Film position deviation ≤0. 15mm		Minor
			Scratch: no control when don't damage the body		
			Overfill/ lack of plastic/ Burr: no control		
			Not control the bubble inside the cover protection film		
50	Easy to tear	Cover surface	Function failure\ damaged\ Missing label: not allowed		
			Wrinkle\ Convex- concave point\ dirty\ punching\ burr\ squeeze out: not control		
51	Composite tape	LTFS	Don't go beyond the edge of panel.		
			Folds\ Light leakage\ Impact assembly or thickness: not allowed		
			Damaged: not allowed		
			Bump does not affect the assembly: not control		
			Punching the bad size meet the drawings requirements: not control		
			Non- wipe dirty\ foreign body: not allowed		
			Foreign objects in accordance with the standard line/ point		
			Burr does not exceed the screened edge: not control		
			Do not have obvious bubbles		
Gum flower\ Overfill: no control					
52	Film warpage	Whole area	Warpage ≤0.2mm		Minor
53	ICON hole	OA area	chromatic aberration、double image、dot defect、line defect: not allowed (or refer to limited sample)		Minor
54	Earpiece hole	OA area	left- right asymmetry, Hole Rather large/ small or off normal(Out of specification) No chamfer, Uneven polishing: not allowed		
55	Ink bumps	OA area	Positive side reference point defects; The backside does not affect the assembly; Ink overflow		

			accumulation: notallowed					
56	Coverconcave convexpoint	Whole area	Front:Height&depth ≤ 0. 15 mm, size ≤ 0.4 mm, if necessaryreferencelimitsample					
			Back: Don’ taffecthefitprocessisnotcontrolled					
57	InsulationTape	Bondin garea	Obvious wrinklesandbubbles: notallowed				Minor	
		Compo nenta rea	Scratch/ Gumflower: notcontrol					
			Non- wipedirty: notallowed					
			Offsetcannotexceedtheedgeoftheproduct, Others arerequiredtothedrawings					
			Burr\ Overfill: notcontrol					
			Damaged/ incomplete/ missingpaste: notallowed					
58	Cover edge/side breakage	Edgeof cover	X	Y	Z	D S	Accepta ble number	Minor
			X<0.2mm	Y<0.2mm	Z≤1/2 t	D S > 5 m m	Unilateral ≤2	
			X>0.2mm	/	/	notallowed		
			/	Y>0.2mm	/	notallowed		
			/	/	Z>1/2T	notallowed		
			Cracksare notallowed					
59	Blunt	Whole area	Not allowed				Fatal flaw	
60	Fitbubble	AA	Accordingtothepunctatespecifications				Minor	
61	Visionareaedge defect	OA	D≤0.2mm， DS> 10,N≤2 （hole saw tusk less than 2） ， ifnecessaryreferencelimitsample.				Minor	
62	Cover heterochrosis	OA	Heterochrosisideexecuteaccordingtopointdefect size,bulk/stickrefertoLimitedsample				Minor	

10 Mechanical Drawing



11 Precautions for Use of AMOLED Modules

11.1 Handling Precautions:

- 11.1.1 The display panel is made of glass. Do not subject it to a mechanical shock by dropping it from height.
- 11.1.2 Do not press down the screen on the adjoining areas too hard because the color tone may be shifted.
- 11.1.3 The polarizer covering the display surface of the AMOLED module is soft and easily scratched. Handle this polarizer carefully.
- 11.1.4 If the display surface is contaminated, blow on the surface and gently wipe it with a soft dry cloth. If it is still not completely clear, moisten the cloth with ethyl alcohol.
- 11.1.5 Solvents may damage the polarizer. Do not use water, ketone or aromatic solvents except ethyl alcohol.
Do not attempt to disassemble the AMOLED Module.
- 11.1.6 If the logic circuit power is off, do not apply the input signals.
- 11.1.7 To prevent destruction from static electricity, be careful to maintain an optimum working environment. Be sure to make yourself in contact with the ground when handling with the AMOLED
- 11.1.8 Modules.
Tools required for assembly, such as soldering irons, must be properly ground.
- 11.1.9 To reduce the generation of static electricity, do not conduct assembly or other work
- 11.1.10 under Dry conditions.
To protect the display surface, the AMOLED Module is coated with a film. Be careful
- 11.1.11 when Peeling off this protective film, because static electricity may generate.

11.2 Storage Precautions:

- 11.2.1 When storing the AMOLED modules, be sure that they are not directly exposed to the sunlight or the light of fluorescent lamps.
- 11.2.2 The AMOLED modules should be stored under the storage temperature range. If the AMOLED modules will be stored for a long time, the recommended condition is: Temperature: 0℃~40℃ Relatively humidity: ≤80%
- 11.2.3 The AMOLED modules should be stored in the room without acid, alkali or harmful gas.

11.3 Transportation Precautions:

- 11.3.1 The AMOLED modules should not be suffered from falling and violent shocking during transportation. Besides, excessive press, water, damp and sunshine, should be avoided.